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MOSFET – N-Channel, Shielded Gate, POWERTRENCH®

150 V, 9.4 A, 134 mΩ

FDMC86244, FDMC86244-L701

General Description

This N-Channel MOSFET is produced using ON Semiconductor's advanced POWERTRENCH process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance.

Features

- Max $r_{DS(on)}$ = 134 mΩ at V_{GS} = 10 V, I_D = 2.8 A
- Max $r_{DS(on)}$ = 186 mΩ at V_{GS} = 6 V, I_D = 2.4 A
- Low Profile – 1 mm Max in Power 33
- 100% UIL Tested
- These Devices are Pb-Free and are RoHS Compliant

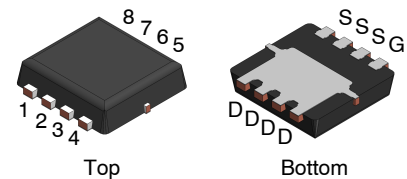
Applications

- DC – DC Conversion

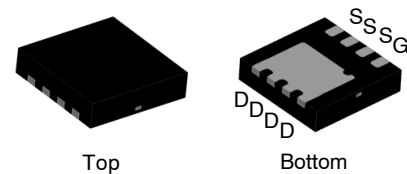


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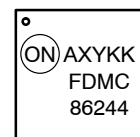


**WDFN8 3.3x3.3, 0.65P
CASE 511DR
FDMC86244**

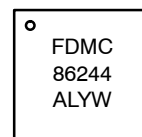


**WDFN8 3.3x3.3, 0.65P
CASE 511DQ
FDMC86244-L701**

MARKING DIAGRAM



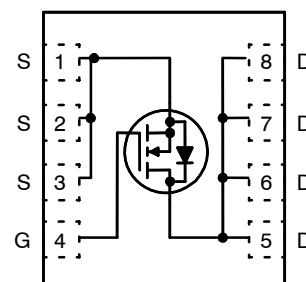
FDMC86244



FDMC86244-L701

FDMC86244 = Specific Device Code
A = Assembly Site
XY = 2-Digit Date Code
KK = 2-Digit Lot Run Traceability Code
L = Wafer Lot Number
YW = Assembly Start Week

PIN ASSIGNMENT



ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

FDMC86244, FDMC86244-L701

MOSFET MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter		Ratings	Unit
V_{DS}	Drain to Source Voltage		150	V
V_{GS}	Gate to Source Voltage		± 20	V
I_D	Drain Current	Continuous	$T_C = 25^\circ\text{C}$	A
		Continuous (Note 2a)	$T_A = 25^\circ\text{C}$	
		Pulsed	12	
E_{AS}	Single Pulse Avalanche Energy (Note 1)		12	mJ
P_D	Power Dissipation		$T_C = 25^\circ\text{C}$	W
	Power Dissipation (Note 2a)		$T_A = 25^\circ\text{C}$	
T_J, T_{STG}	Operating and Storage Junction Temperature Range		-55 to +150	$^\circ\text{C}$

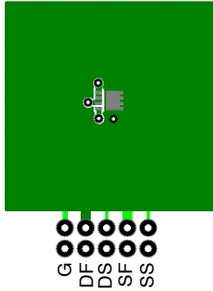
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Starting $T_J = 25^\circ\text{C}$; N-ch: $L = 1.0\text{ mH}$, $I_{AS} = 5.0\text{ A}$, $V_{DD} = 135\text{ V}$, $V_{GS} = 10\text{ V}$.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case	4.7	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 2a)	125	

2. $R_{\theta JA}$ is determined with the device mounted on a 1 in^2 pad 2 oz copper pad on a $1.5 \times 1.5\text{ in.}$ board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 53°C/W when mounted on a 1 in^2 pad of 2 oz copper



b. 125°C/W when mounted on a minimum pad of 2 oz copper

FDMC86244, FDMC86244-L701

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	150	–	–	V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25°C	–	106	–	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 120 V, V _{GS} = 0 V	–	–	1	μA
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±20 V, V _{DS} = 0 V	–	–	±100	nA

ON CHARACTERISTICS

V _{GS(th)}	Gate to Source Threshold Voltage	V _{GS} = V _{DS} , I _D = 250 μA	2	2.6	4	V
ΔV _{GS(th)} / ΔT _J	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25°C	–	–9	–	mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 2.8 A	–	105	134	mΩ
		V _{GS} = 6 V, I _D = 2.4 A	–	120	186	
		V _{GS} = 10 V, I _D = 2.8 A, T _J = 125°C	–	199	254	
g _{FS}	Forward Transconductance	V _{DS} = 10 V, I _D = 2.8 A	–	8	–	S

DYNAMIC CHARACTERISTICS

C _{iss}	Input Capacitance	V _{DS} = 75 V, V _{GS} = 0 V, f = 1 MHz	–	257	345	pF
C _{oss}	Output Capacitance		–	32	45	pF
C _{rss}	Reverse Transfer Capacitance		–	1.8	5	pF

SWITCHING CHARACTERISTICS

t _{d(on)}	Turn-On Delay Time	V _{DD} = 75 V, I _D = 2.8 A, V _{GS} = 10 V, R _{GEN} = 6 Ω	–	5.3	11	ns
t _r	Rise Time		–	1.5	10	ns
t _{d(off)}	Turn-Off Delay Time		–	9.9	20	ns
t _f	Fall Time		–	2.3	10	ns
Q _{g(TOT)}	Total Gate Charge	V _{GS} = 0 V to 10 V, V _{DD} = 75 V, I _D = 2.8 A	–	4.2	5.9	nC
Q _{g(TOT)}	Total Gate Charge	V _{GS} = 0 V to 5 V, V _{DD} = 75 V, I _D = 2.8 A	–	2.4	3.4	nC
Q _{gs}	Total Gate Charge	V _{DD} = 75 V, I _D = 2.8 A	–	1.1	–	nC
Q _{gd}	Gate to Drain “Miller” Charge		–	1.0	–	nC

DRAIN-SOURCE DIODE CHARACTERISTICS

V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 2.8 A (Note 3)	–	0.81	1.3	V
		V _{GS} = 0 V, I _S = 2 A (Note 3)	–	0.79	1.2	
t _{rr}	Reverse Recovery Time	I _F = 2.8 A, di/dt = 100 A/μs	–	48	76	ns
Q _{rr}	Reverse Recovery Charge		–	38	61	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0%.

TYPICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

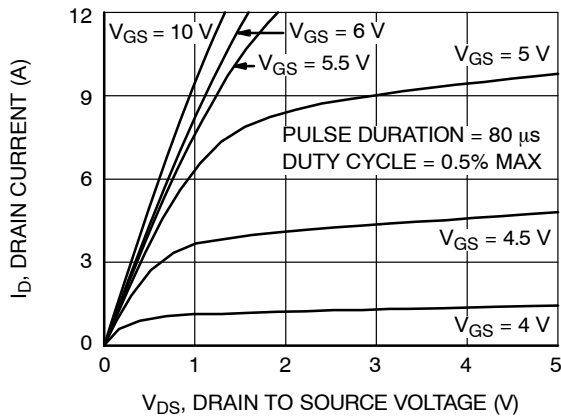


Figure 1. On Region Characteristics

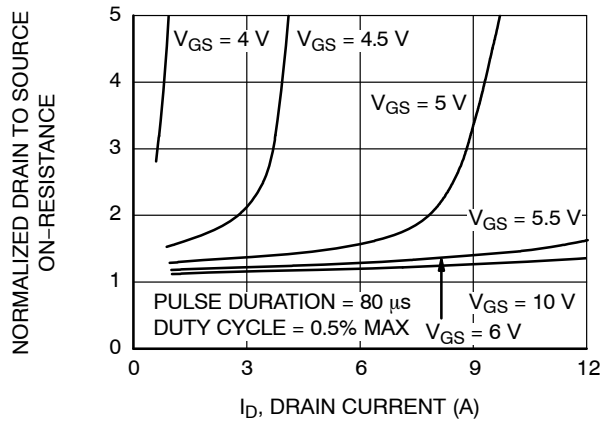


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

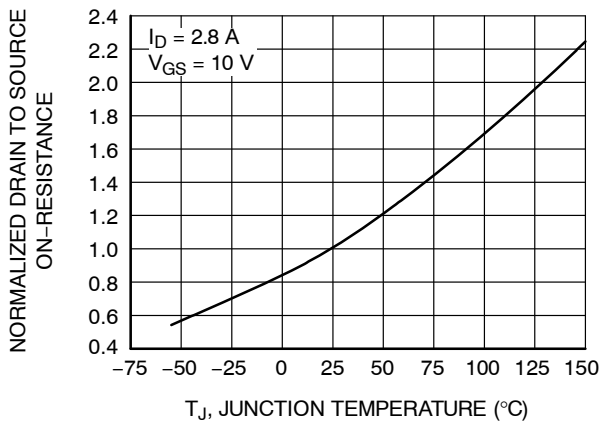


Figure 3. Normalized On Resistance vs. Junction Temperature

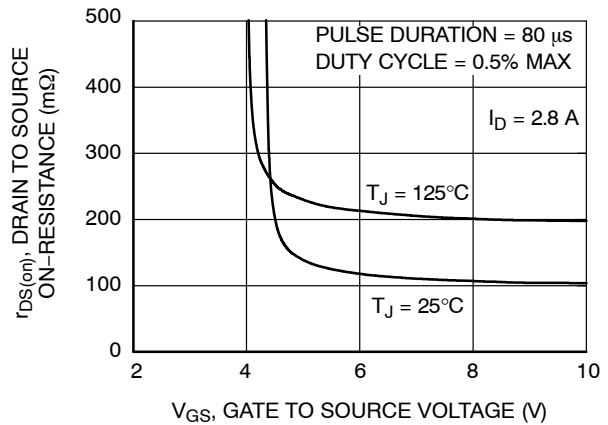


Figure 4. On-Resistance vs. Gate to Source Voltage

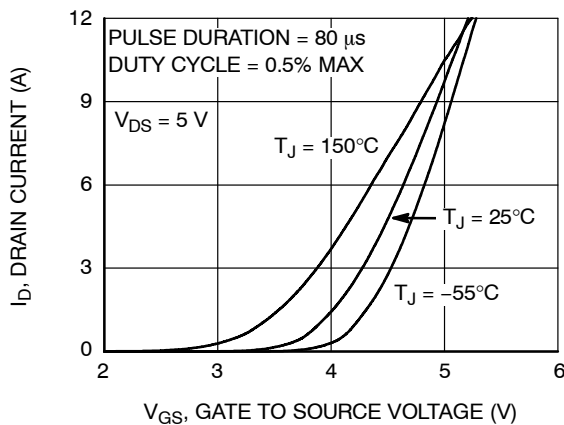


Figure 5. Transfer Characteristics

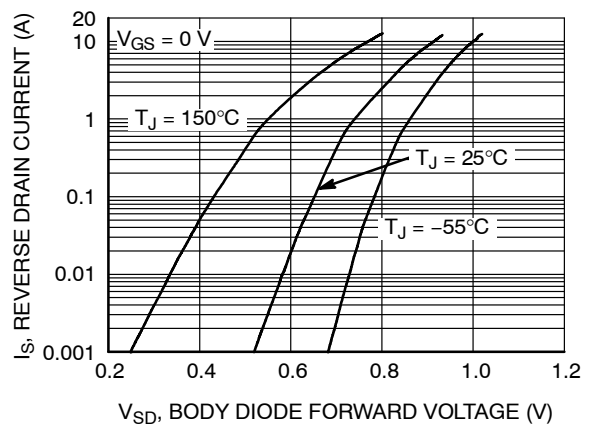


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted) (continued)

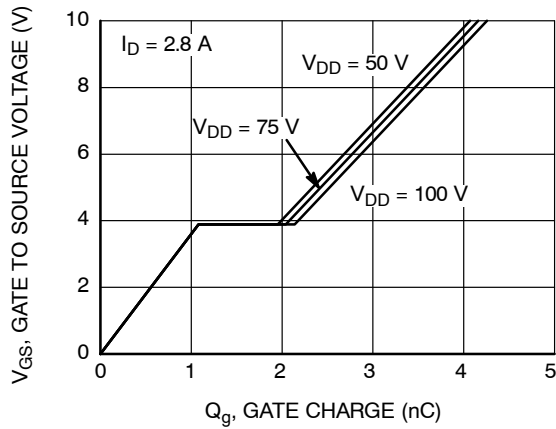


Figure 7. Gate Charge Characteristics

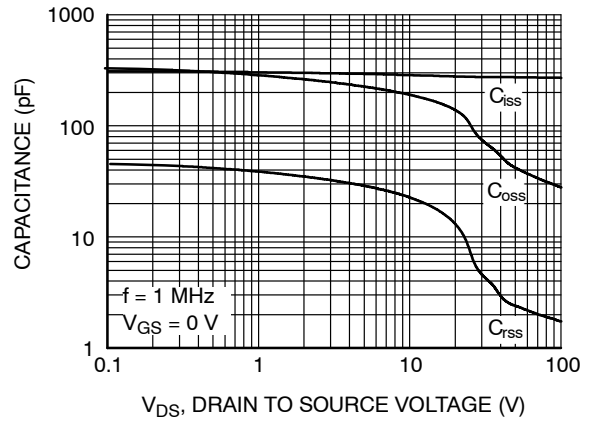


Figure 8. Capacitance vs. Drain to Source Voltage

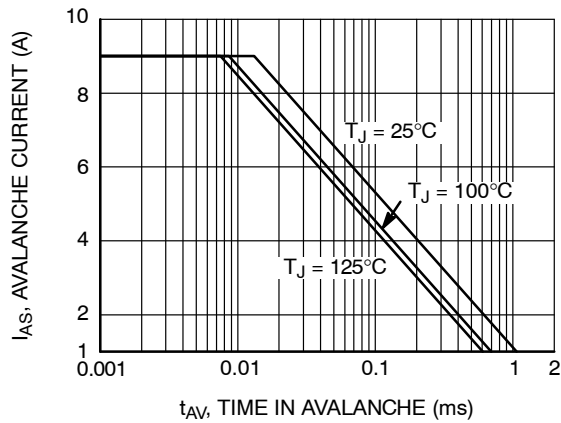


Figure 9. Unclamped Inductive Switching Capability

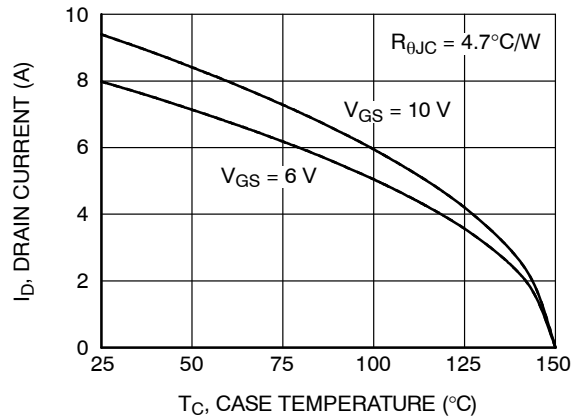


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

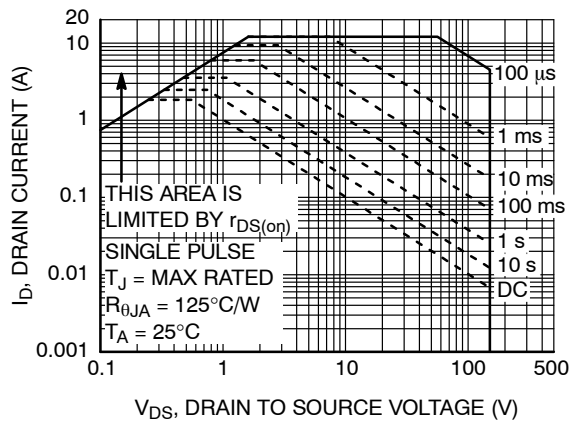


Figure 11. Forward Bias Safe Operating Area

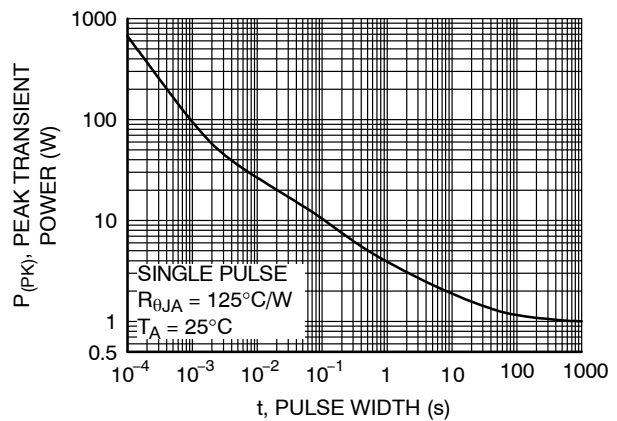


Figure 12. Single Pulse Maximum Power Dissipation

FDMC86244, FDMC86244-L701

TYPICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted) (continued)

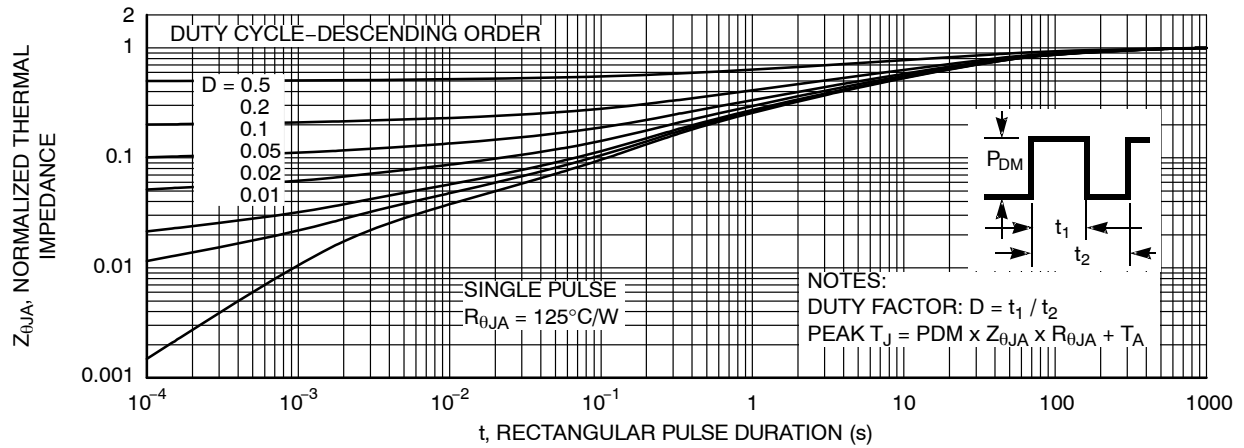
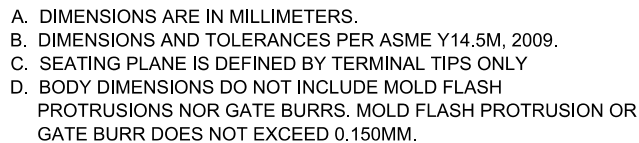


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

ORDERING INFORMATION

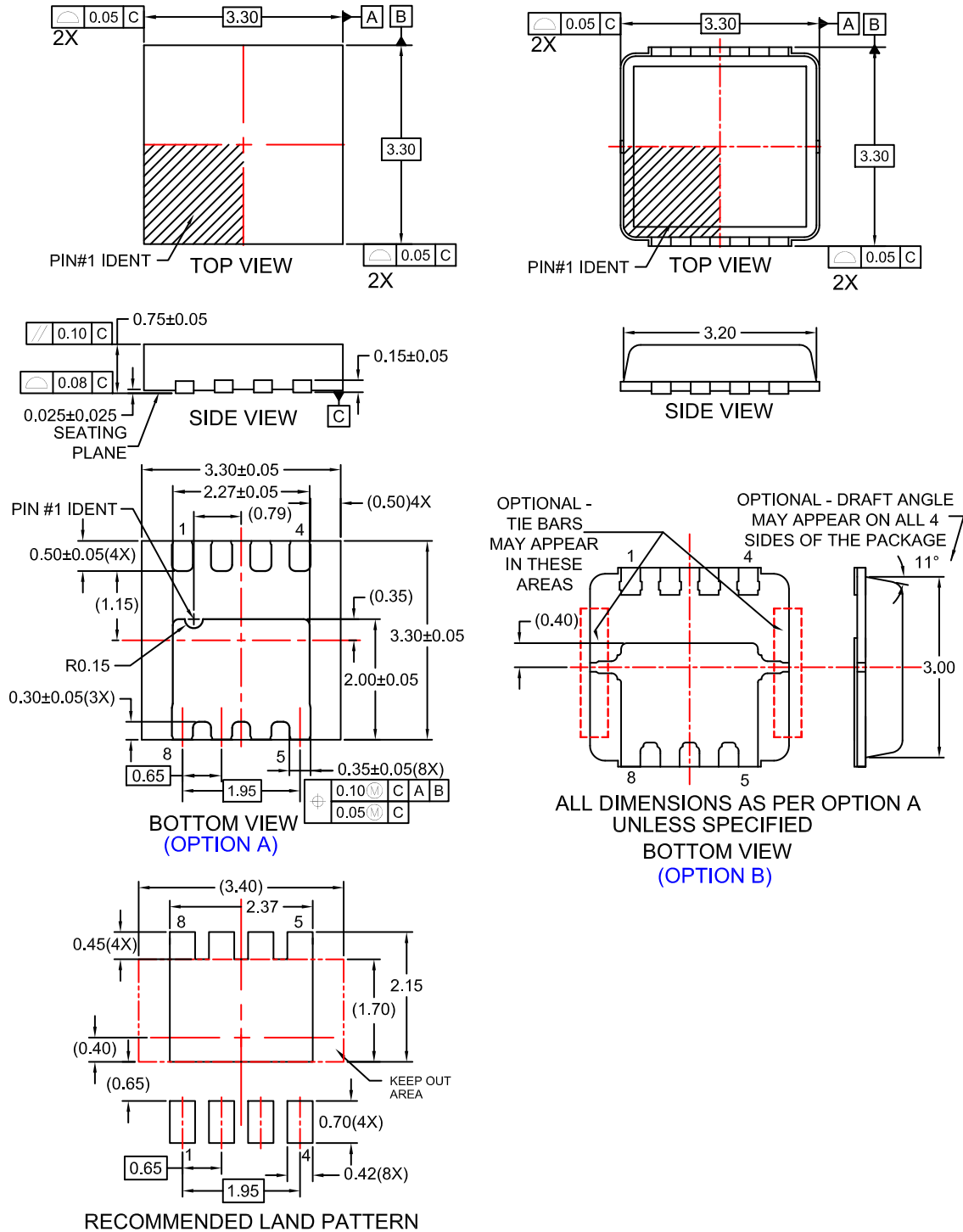
Device	Device Marking	Package Type	Reel Size	Tape Width	Shipping [†]
FDMC86244	FDMC86244	WDFN8 3.3x3.3, 0.65P Power 33 (Pb-Free)	13"	12 mm	3000 / Tape & Reel
FDMC86244-L701	FDMC86244	WDFN8 3.3x3.3, 0.65P Power 33 (Pb-Free)	13"	12 mm	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



PACKAGE DIMENSIONS

WDFN8 3.3x3.3, 0.65P
CASE 511DQ
ISSUE O



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